

Search Notes**Application/Control No.**

10/691,212

**Applicant(s)/Patent under
Reexamination**

DORNBUSCH ET AL.

Examiner

CHRIS C. CHU

Art Unit

2815

SEARCHED

Class	Subclass	Date	Examiner
257	E23.052, E23.079, 766 & 778	2/26/2008	C.C.
257	686	2/26/2008	C.C.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched in US-PGPUB, USPAT; USOCR; EPO; JPO; DERWENT; FPRS; and IBM_TDB;	2/26/2008	C.C.